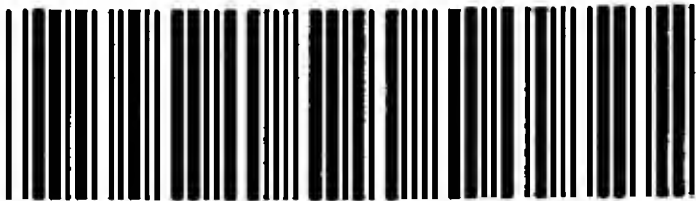


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,097	WENG, YIH-SHIN	
	Examiner	Art Unit	
	Parul Gupta	2627	

SEARCHED			
Class	Subclass	Date	Examiner
369	47.34	4/27/2006	PG
369	53.2-53.2	4/27/2006	PG

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted Wayne Young, who provided search help.	4/27/2006	PG
See search history printout.	4/27/2006	PG